



TLC6C598 8ビット・シフト・レジスタLEDドライバ

1 特長

- 3V~5.5Vの広い V_{CC}
- 出力最大定格40V
- 8個のパワーDMOSトランジスタにより、 $V_{CC} = 5V$ で50mAの連続電流を出力、または1ms未満の単一パルス期間および50mA未満の平均電流で200mAのPWM電流を出力
- サーマル・シャットダウン保護機能
- 拡張カスケードにより複数のステージが可能
- 単一の入力ですべてのレジスタをクリア
- 低消費電力
- 低速なスイッチング時間(t_r および t_f)により、EMIを大幅に低減
- 16ピンのTSSOP-PWパッケージ

2 アプリケーション

- 家電機器用ディスプレイ・パネル
- エレベータ用ディスプレイ・パネル
- PLC用機能インジケータ
- 7セグメント・ディスプレイ

3 概要

TLC6C598は、モノリシックで中程度の電圧、低電流出力の8ビット・シフト・レジスタで、LEDなど、比較的中程度の負荷電力を必要とするシステムで使用するよう設計されています。

このデバイスには、8ビットのシリアル・イン、パラレル・アウトのシフト・レジスタが内蔵されており、8ビットのDタイプ・ストレージ・レジスタへデータを供給します。シフト・レジスタとストレージ・レジスタの両方に、それぞれ独立したクロックが供給されます。出力はローサイドのオープン・ドレインDMOSトランジスタで、出力定格は40Vです。 $V_{CC} = 5V$ のとき、50mAの連続シンク電流、または1ms未満の単一パルス期間および50mA未満の平均電流で200mAのPWM電流を出力します。デバイスにはサーマル・シャットダウン保護が内蔵されており、人体モデルを使用したテストで2000V、マシン・モデルでは200VまでのESD保護を提供します。

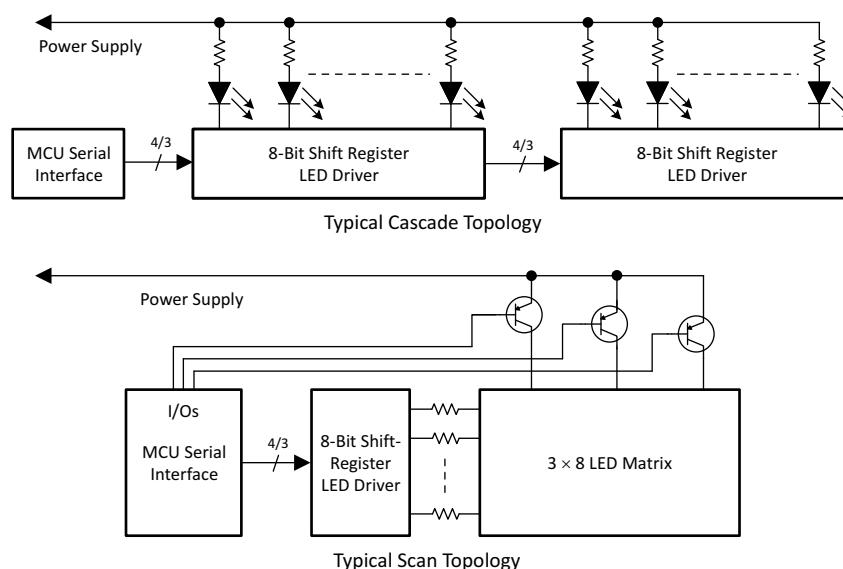
TLC6C598の特性は、 $-40^{\circ}\text{C} \sim 105^{\circ}\text{C}$ の動作時周辺温度範囲での動作についてのものです。

製品情報⁽¹⁾

型番	パッケージ	本体サイズ(公称)
TLC6C598	TSSOP (16)	5.00mm×4.40mm

(1) 提供されているすべてのパッケージについては、巻末の注文情報を参照してください。

代表的なアプリケーションの回路図



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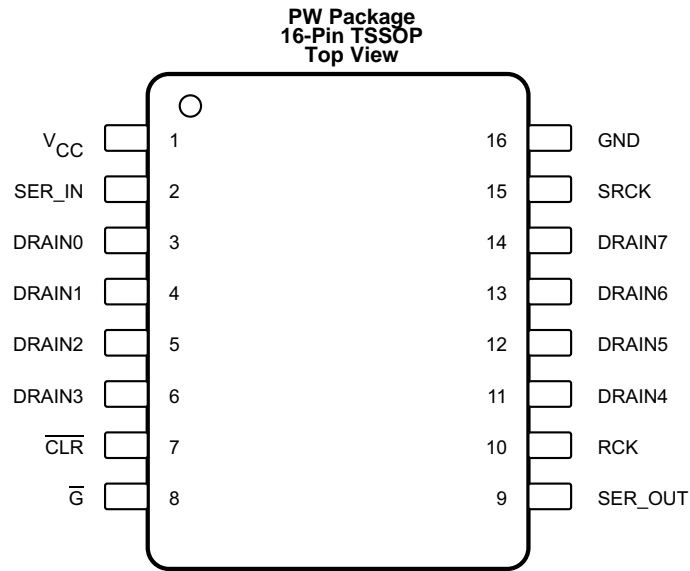
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4 改訂履歴

日付	改訂内容	注
2016年5月	*	初版

5 Pin Configuration and Functions



Pin Functions

PIN		I/O	DESCRIPTION
NAME	NO.		
$\overline{\text{CLR}}$	7	I	Shift register clear, active-low. The storage register transfers data to the output buffer when CLR is high. Driving CLR low clears all the registers in the device.
DRAIN0	3	O	Open-drain output, LED current-sink channel, connect to LED cathode
DRAIN1	4	O	Open-drain output, LED current-sink channel, connect to LED cathode
DRAIN2	5	O	Open-drain output, LED current-sink channel, connect to LED cathode
DRAIN3	6	O	Open-drain output, LED current-sink channel, connect to LED cathode
DRAIN4	11	O	Open-drain output, LED current-sink channel, connect to LED cathode
DRAIN5	12	O	Open-drain output, LED current-sink channel, connect to LED cathode
DRAIN6	13	O	Open-drain output, LED current-sink channel, connect to LED cathode
DRAIN7	14	O	Open-drain output, LED current-sink channel, connect to LED cathode
$\overline{\text{G}}$	8	I	Output enable, active-low. LED-channel enable and disable input pin. Having $\overline{\text{G}}$ low enables all drain channels according to the output-latch register content. When high, all channels are off.
GND	16	—	Power ground, the ground reference pin for the device. This pin must connect to the ground plane on the PCB.
RCK	10	I	Register clock. The data in each shift register stage transfers to the storage register at the rising edge of RCK.
SER IN	2	I	Serial data input. Data on SER IN loads into the internal register on each rising edge of SRCK.
SER OUT	9	O	Serial data output of the 8-bit serial shift register. The purpose of this pin is to cascade several devices on the serial bus.
SRCK	15	I	Serial clock input. On each rising SRCK edge, data transfers from SER IN to the internal serial shift registers.
V _{CC}	1	I	Power supply pin for the device. TI recommends adding a 0.1-μF ceramic capacitor close to the pin.

6 Specifications

6.1 Absolute Maximum Ratings

over operating ambient temperature range (unless otherwise noted)⁽¹⁾

		MIN	MAX	UNIT
V _{CC}	Logic supply voltage	−0.3	8	V
V _I	Logic input-voltage range	−0.3	8	V
V _{DS}	Power DMOS drain-to-source voltage	−0.3	42	V
	Continuous total dissipation	See Thermal Information		
T _J	Operating junction temperature range	−40	125	°C
T _{stg}	Storage temperature range	−55	165	°C

- (1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, and do not imply functional operation of the device at these or any other conditions beyond those indicated under [Recommended Operating Conditions](#). Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

6.2 ESD Ratings

			VALUE	UNIT
V _(ESD)	Electrostatic discharge	Human body model (HBM), per AEC Q100-002 ⁽¹⁾	±2000	V
		Charged device model (CDM), per AEC Q100-011	±750	
			±750	

- (1) AEC Q100-002 indicates HBM stressing is done in accordance with the ANSI/ESDA/JEDEC JS-001 specification.

6.3 Recommended Operating Conditions

		MIN	MAX	UNIT
V _{CC}	Supply voltage	3	5.5	V
V _{IH}	High-level input voltage	2.4		V
V _{IL}	Low-level input voltage		0.7	V
T _A	Operating ambient temperature	−40	105	°C

6.4 Thermal Information

THERMAL METRIC ⁽¹⁾		TLC6C598	UNIT
		PW (TSSOP)	
		16 PINS	
R _{θJA}	Junction-to-ambient thermal resistance	129.4	°C/W
R _{θJC(top)}	Junction-to-case (top) thermal resistance	55.4	°C/W
R _{θJB}	Junction-to-board thermal resistance	65.8	°C/W
ψ _{JT}	Junction-to-top characterization parameter	9.9	°C/W
ψ _{JB}	Junction-to-board characterization parameter	65.2	°C/W

- (1) For more information about traditional and new thermal metrics, see the *Semiconductor and IC Package Thermal Metrics* application report ([SPRA953](#)).

6.5 Electrical Characteristics

 $V_{CC} = 5\text{ V}$, $T_A = 25^\circ\text{C}$ (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
DRAIN0 to DRAIN7. Drain-to-source voltage				40			V
V _{OH}	High-level output voltage, SER OUT	I _{OH} = −20 μA	V _{CC} = 5 V	4.9	4.99		V
		I _{OH} = −4 mA		4.5	4.69		V
V _{OL}	Low-level output voltage, SER OUT	I _{OH} = 20 μA	V _{CC} = 5 V		0.001	0.01	V
		I _{OH} = 4 mA			0.25	0.4	V
I _{IH}	High-level input current	V _{CC} = 5 V, V _I = V _{CC}			0.2		μA
I _{IL}	Low-level input current	V _{CC} = 5 V, V _I = 0			−0.2		μA
I _{CC}	Logic supply current	V _{CC} = 5 V, no clock signal	All outputs off	0.1	1	μA	
			All outputs on	88	160		
I _{CC(FRQ)}	Logic supply current at frequency	f _{SRCK} = 5 MHz, C _L = 30 pF	All outputs on	200		μA	
I _{DSx}	Off-state drain current	V _{DS} = 30 V	V _{CC} = 5 V	0.1		μA	
		V _{DS} = 30 V, T _C = 105°C	V _{CC} = 5 V	0.15 0.3			
r _{DS(on)}	Static drain-source on-state resistance	I _D = 20 mA, V _{CC} = 5 V, T _A = 25°C, Single channel ON		6	7.41	8.6	Ω
		I _D = 20 mA, V _{CC} = 5 V, T _A = 25°C, All channels ON		6.7	8.3	9.6	
		I _D = 20 mA, V _{CC} = 3.3 V, T _A = 25°C, Single channel ON		7.9	9.34	11.2	
		I _D = 20 mA, V _{CC} = 3.3 V, T _A = 25°C, All channels ON		8.7	10.25	12.3	
		I _D = 20 mA, V _{CC} = 5 V, T _A = 105°C, Single channel ON		9.1	11.13	12.9	
		I _D = 20 mA, V _{CC} = 5 V, T _A = 105°C, All channels ON		10.3	12.28	14.5	
		I _D = 20 mA, V _{CC} = 3.3 V, T _A = 105°C, Single channel ON		11.6	13.69	16.4	
		I _D = 20 mA, V _{CC} = 3.3 V, T _A = 105°C, All channels ON		12.8	14.89	18.2	
T _{SHUTDOWN}	Thermal shutdown trip point			150	175	200	°C
T _{hys}	Hysteresis			15		°C	

6.6 Timing Requirements

		MIN	NOM	MAX	UNIT
t_{su}	Setup time, SER IN high before SRCK \uparrow	15			ns
t_h	Hold time, SER IN high after SRCK \uparrow	15			ns
t_w	SER IN pulse duration	40			ns

TLC6C598

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6.7 Switching Characteristics
 $V_{CC} = 5\text{ V}$, $T_A = 25^\circ\text{C}$

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
t_{PLH}	Propagation delay time from \overline{G} to output, low-to-high level	$C_L = 30\text{ pF}$, $I_D = 48\text{ mA}$		220		ns
t_{PHL}	Propagation delay time from \overline{G} to output, high-to-low level			75		ns
t_r	Rise time, drain output			210		ns
t_f	Fall time, drain output			128		ns
t_{pd}	Propagation delay time, SRCK \downarrow to SER OUT	$C_L = 30\text{ pF}$, $I_D = 48\text{ mA}$		49.4		ns
t_{or}	SER OUT rise time (10% to 90%)	$C_L = 30\text{ pF}$		20		ns
t_{of}	SER OUT fall time (90% to 10%)	$C_L = 30\text{ pF}$		20		ns
$f_{(SRCK)}$	Serial clock frequency	$C_L = 30\text{ pF}$, $I_D = 20\text{ mA}$			10	MHz
t_{SRCK_WH}	SRCK pulse duration, high		30			ns
t_{SRCK_WL}	SRCK pulse duration, low		30			ns

6.8 Timing Waveforms

Figure 1 shows the SER IN to SER OUT waveform. The output signal appears on the falling edge of the shift register clock (SRCK) because there is a phase inverter at SER OUT (see Figure 13). As a result, it takes seven and a half periods of SRCK for data to transfer from SER IN to SER OUT.

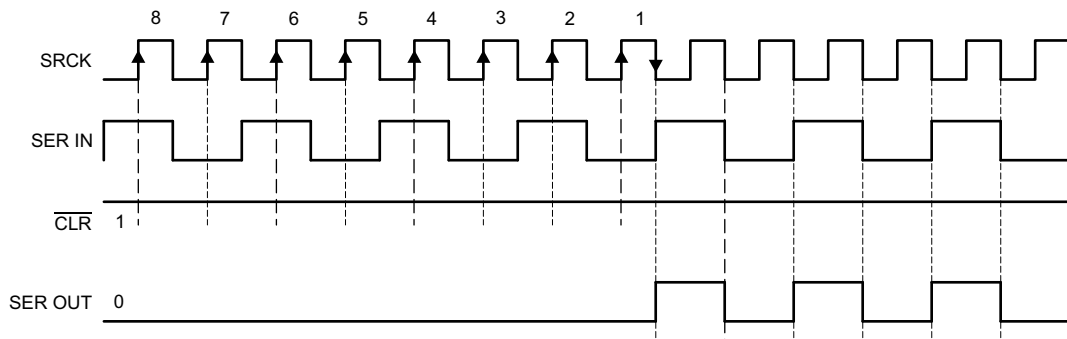


Figure 1. SER IN to SER OUT Waveform

Figure 2 shows the switching times and voltage waveforms. Tests for all these parameters took place using the test circuit shown in Figure 11.

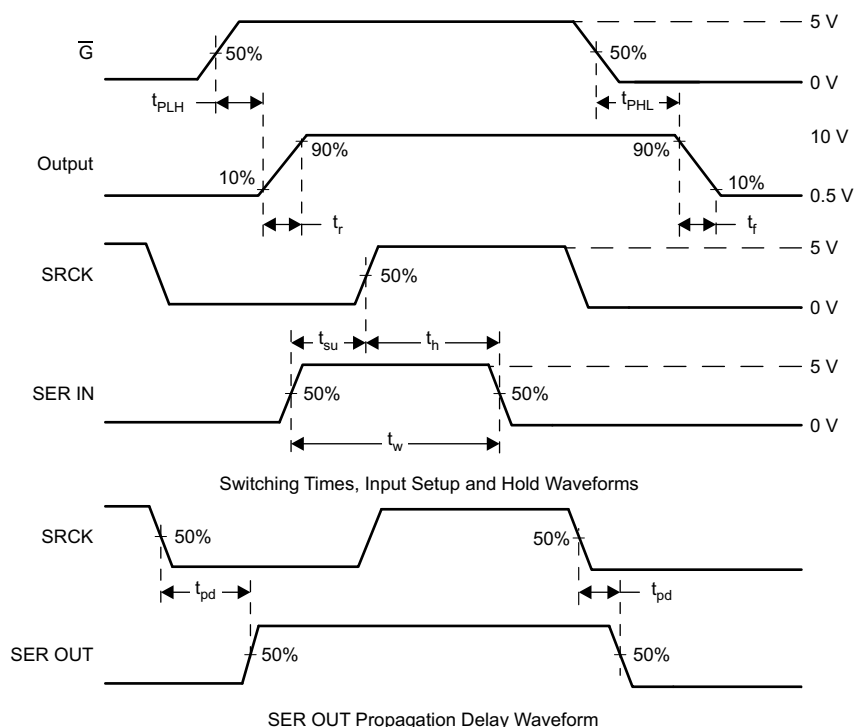


Figure 2. Switching Times and Voltage Waveforms

6.9 Typical Characteristics

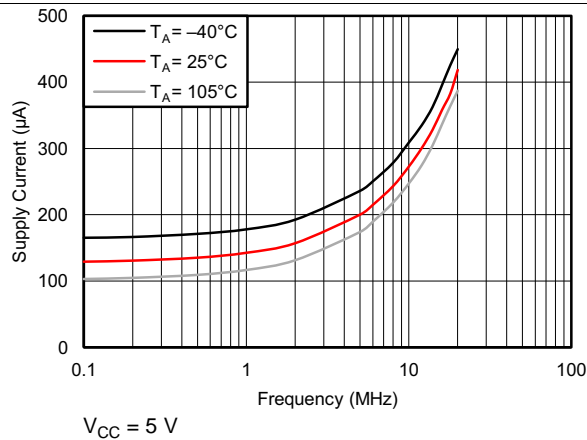


FIG 3. Supply Current vs Frequency

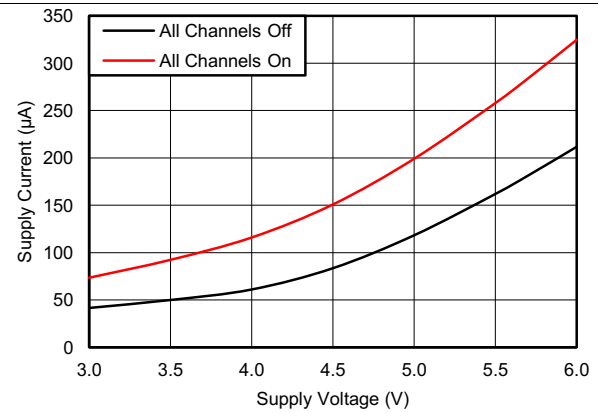


FIG 4. Supply Current vs Supply Voltage

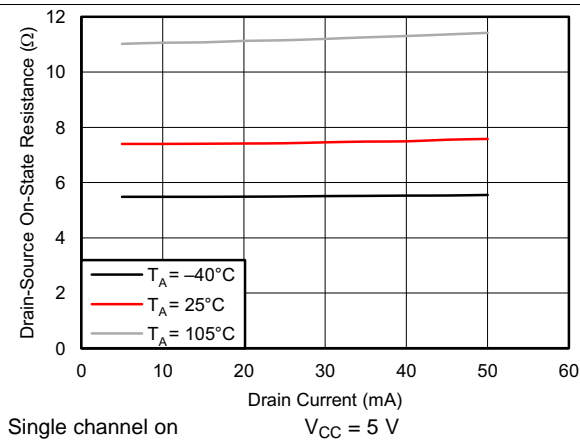


FIG 5. Drain-to-Source On-State Resistance vs Drain Current

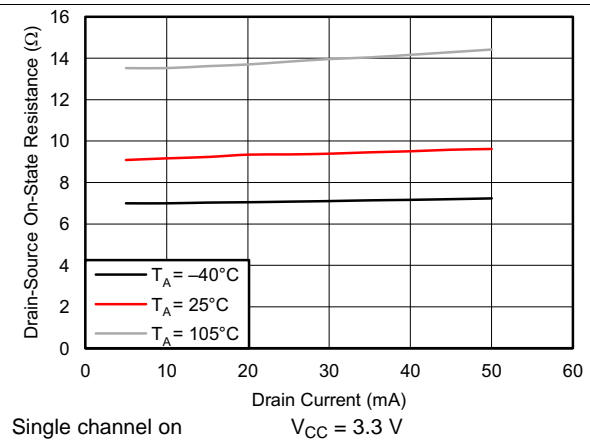


FIG 6. Drain-to-Source On-State Resistance vs Drain Current

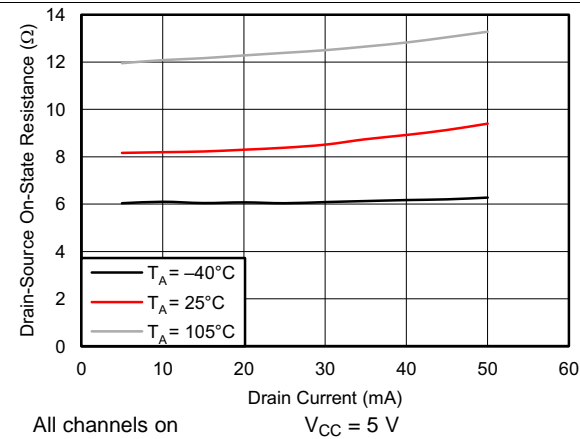


FIG 7. Drain-to-Source On-State Resistance vs Drain Current

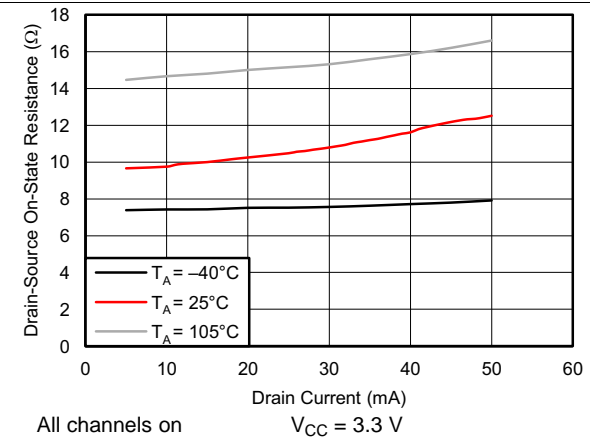


FIG 8. Drain-to-Source On-State Resistance vs Drain Current

Typical Characteristics (continued)

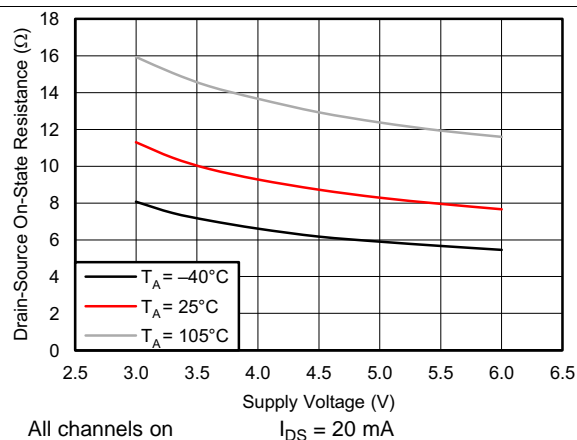


Figure 9. Drain-to-Source On-State Resistance vs Supply Voltage

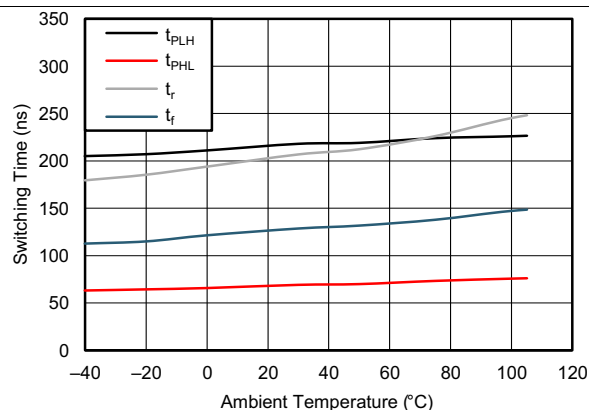
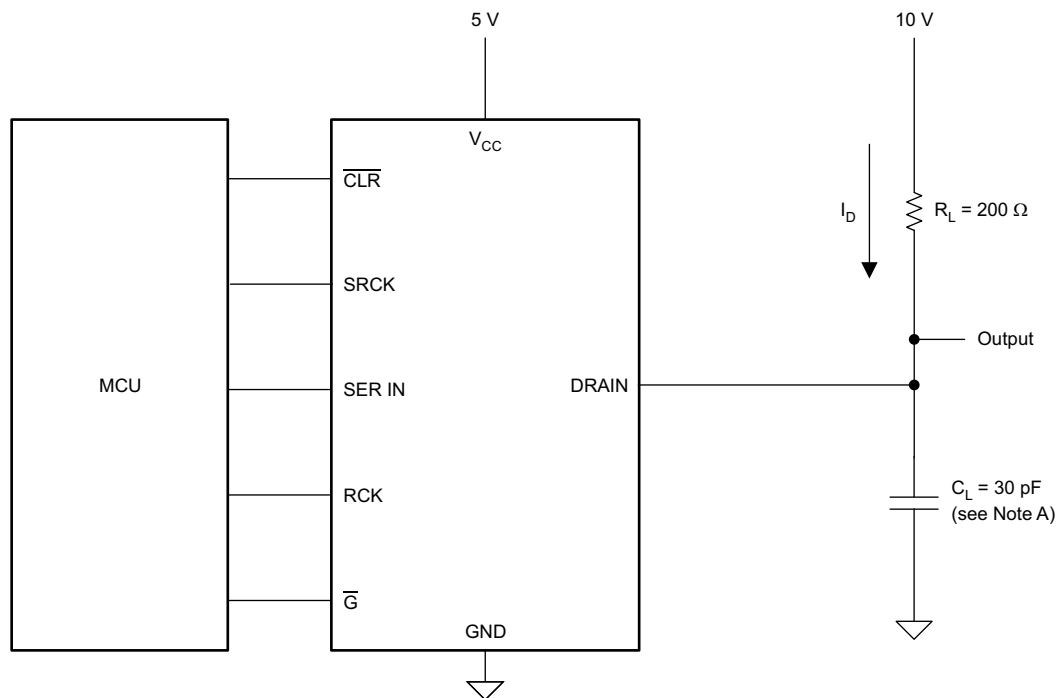


Figure 10. Switching Time vs Ambient Temperature

7 Parameter Measurement Information

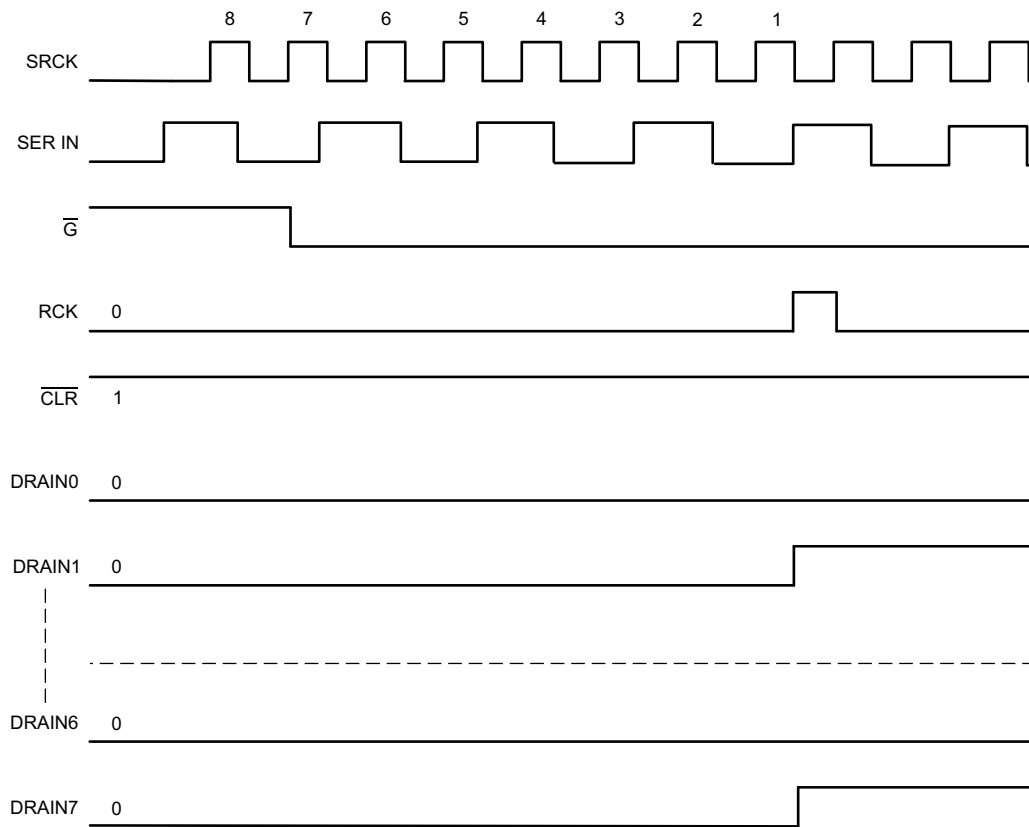
Figure 11 and Figure 12 show the resistive-load test circuit and voltage waveforms. One can see from Figure 12 that with \overline{G} held low and \overline{CLR} held high, the status of each drain changes on the rising edge of the register clock, indicating the transfer of data to the output buffers at that time.



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A. C_L includes probe and jig capacitance.

Figure 11. Resistive-Load Test Circuit

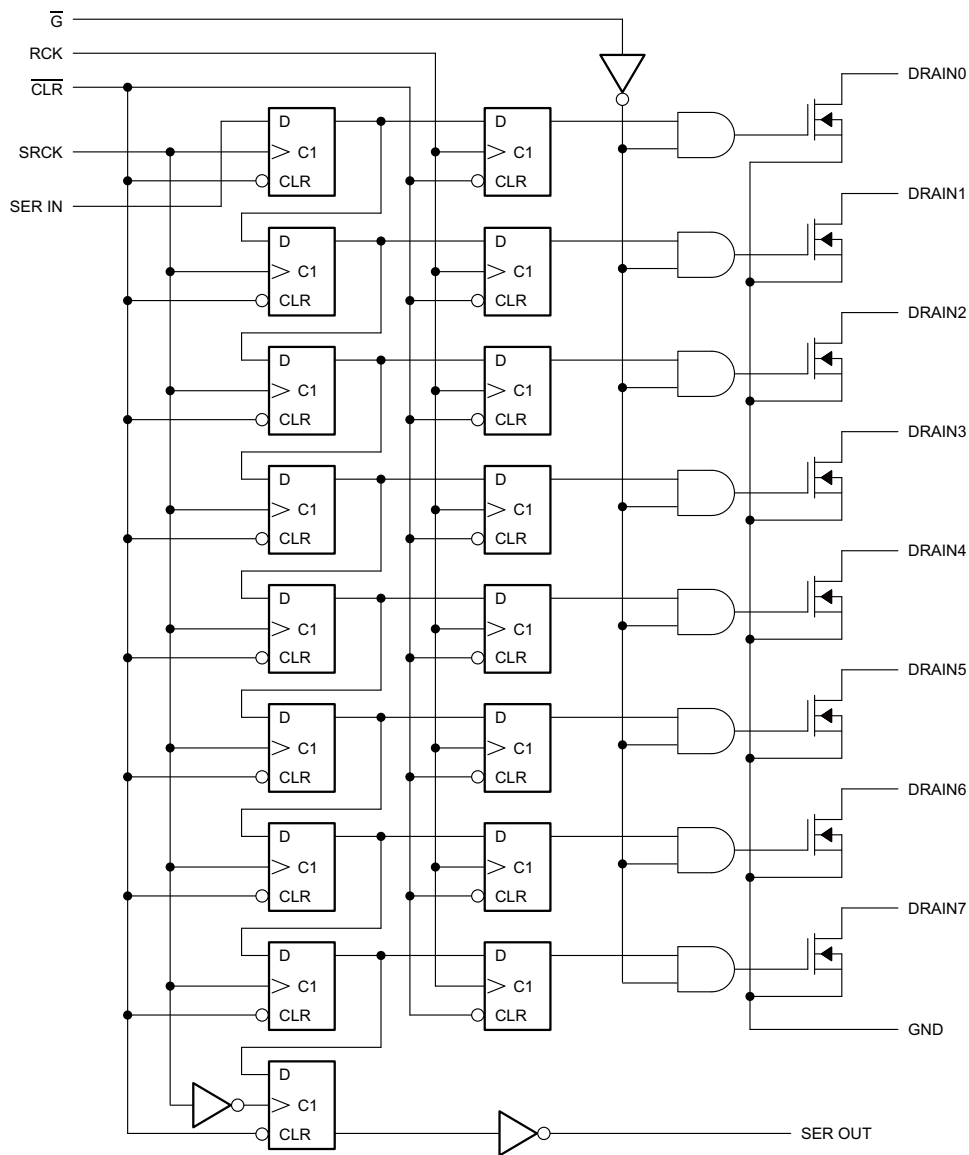
Parameter Measurement Information (continued)

FIG 12. Voltage Waveforms

8 Detailed Description

8.1 Overview

The TLC6C598 device is a monolithic, medium-voltage, low-current 8-bit shift register designed to drive relatively moderate load power such LEDs. The device contains an 8-bit serial-in, parallel-out shift register that feeds an 8-bit D-type storage register. Thermal shutdown protection is also built-into the device.

8.2 Functional Block Diagram



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FIG 13. Logic Diagram (Positive) of TLC6C598

8.3 Feature Description

8.3.1 Thermal Shutdown

The device implements an internal thermal shutdown to protect itself if the junction temperature exceeds 175°C (typical). The thermal shutdown forces the device to have an open state when the junction temperature exceeds the thermal trip threshold. Once the junction temperature decreases below 160°C (typical), the device begins to operate again.

8.3.2 Serial-In Interface

The TLC6C598 device contains an 8-bit serial-in, parallel-out shift register that feeds an 8-bit D-type storage register. Data transfer through the shift and storage registers is on the rising edge of the shift register clock (SRCK) and the register clock (RCK), respectively. The storage register transfers data to the output buffer when shift-register clear ($\overline{\text{CLR}}$) is high.

8.3.3 Clear Registers

A logic low on the $\overline{\text{CLR}}$ pin clears all registers in the device. TI suggests clearing the device during power up or initialization.

8.3.4 Output Channels

DRAIN0–DRAIN7. These pins can survive up to 40-V LED supply voltage.

8.3.5 Register Clock

RCK is the storage-register clock. Data in the storage register appears at the output whenever the output enable ($\overline{\text{G}}$) input signal is high.

8.3.6 Cascade Through SER OUT

By connecting the SER OUT pin to the SER IN input of the next device on the serial bus in cascade, the data transfers to the next device on the falling edge of SRCK. This connection can improve the cascade application reliability, as it can avoid the issue that the second device receives SRCK and data input on the same rising edge of SRCK.

8.3.7 Output Control

Holding the output enable (pin $\overline{\text{G}}$) high holds all data in the output buffers low, and all drain outputs are off. Holding $\overline{\text{G}}$ low makes data from the storage register transparent to the output buffers. When data in the output buffers is low, the DMOS transistor outputs are off. When data is high, the DMOS transistor outputs are capable of sinking current. This pin also can be used for global PWM dimming.

8.4 Device Functional Modes

8.4.1 Operation With $V_{\text{CC}} < 3 \text{ V}$

This device works normally within the range $3 \text{ V} \leq V_{\text{CC}} \leq 5.5 \text{ V}$. When the operating voltage is lower than 3 V, correct behavior of the device, including communication interface and current capability, is not assured.

8.4.2 Operation With $5.5 \text{ V} \leq V_{\text{CC}} \leq 8 \text{ V}$

The device works normally in this voltage range, but reliability issues may occur if the device works for a long time in this voltage range.

9 Application and Implementation

注

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

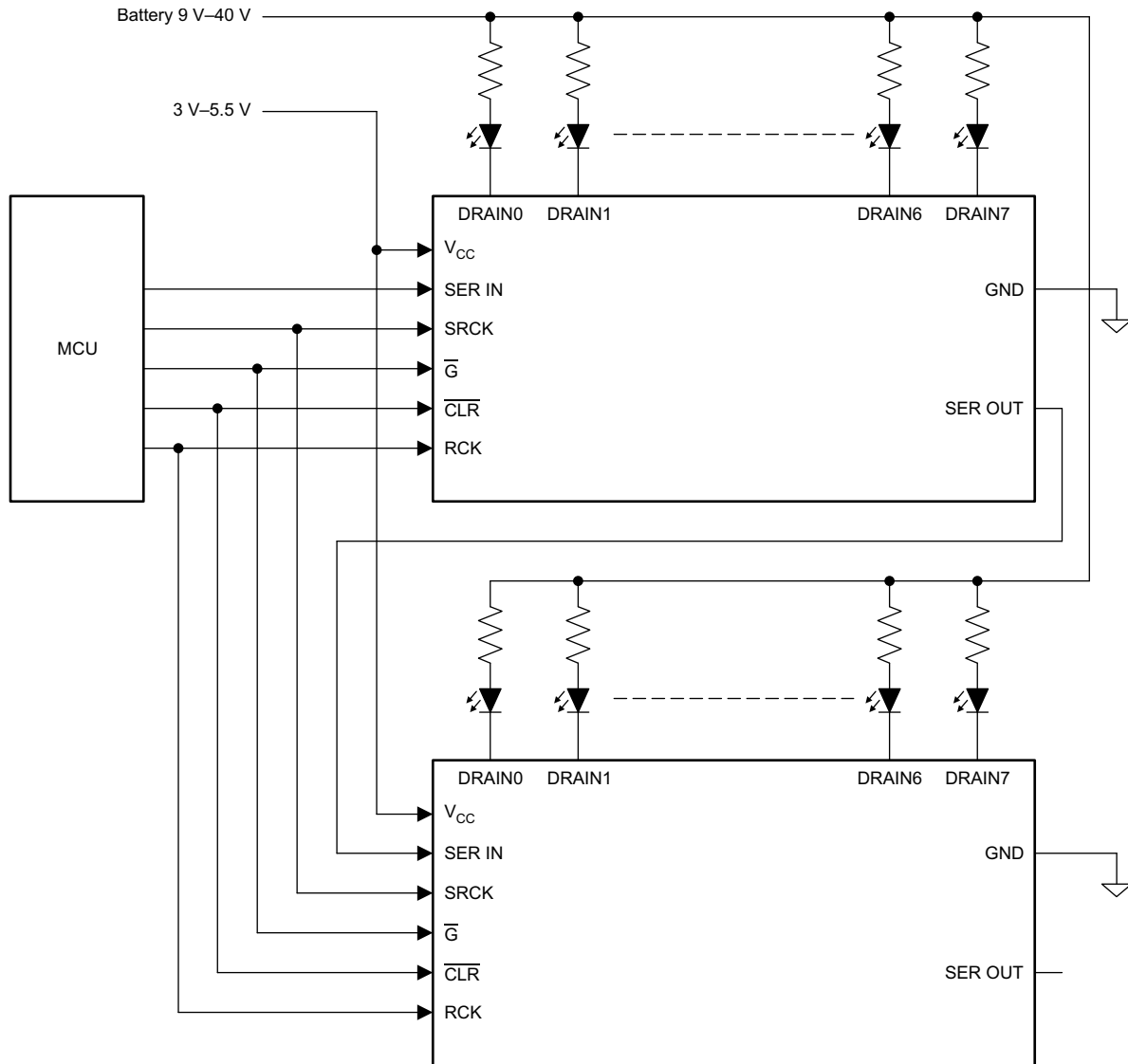
9.1 Application Information

The TLC6C598 device is a serial-in, parallel-out, power and logic, 8-bit shift register with low-side open-drain DMOS output ratings of 40-V and 50-mA continuous sink-current capabilities when $V_{CC} = 5\text{ V}$. The device is designed to drive resistive loads and is particularly well-suited as an interface between a microcontroller and LEDs or lamps. The device also provides up to 2000 V of ESD protection when tested using the human body model and 200 V when using the machine model.

9.2 Typical Application

Figure 14 shows a typical cascade application circuit with two TLC6C598 chips configured in cascade topology. The MCU generates all the input signals.

Typical Application (continued)



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图 14. Typical Application Circuit

9.2.1 Design Requirements

DESIGN PARAMETER	EXAMPLE VALUE
V _{Battery}	9 V to 40 V
V _{CC_1}	3.3 V
I(D0), I(D1), I(D2), I(D3), I(D4), I(D5), I(D6), I(D7)	30 mA
V _{CC_2}	5 V
I(D8), I(D9), I(D10), I(D11), I(D12), I(D13), I(D14), I(D15)	50 mA

9.2.2 Detailed Design Procedure

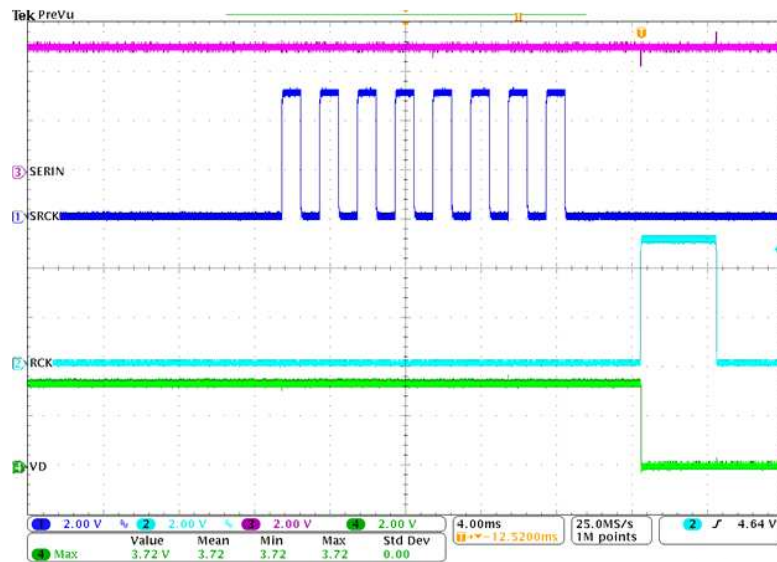
To begin the design process, the designer must decide on a few parameters, as follows:

- V_{supply} : LED supply voltage
- V_{Dx} : LED forward voltage
- I : LED current

With these parameters determined, the resistor in series with the LED can be calculated by using the following equation:

$$R_X = (V_{\text{Supply}} - V_{\text{Dx}}) / I \quad (1)$$

9.2.3 Application Curve



15. TLC6C598 Application Waveform

10 Power Supply Recommendations

The TLC6C598 device is designed to operate with an input voltage supply range from 3 V to 5.5 V. This input supply should be well regulated. TI recommends placing the ceramic bypass capacitors near the V_{CC} pin.

11 Layout

11.1 Layout Guidelines

There are no special layout requirements for the digital signal pins. The only requirement is placing the ceramic bypass capacitors near the corresponding pins.

Maximize the copper coverage on the PCB to increase the thermal conductivity of the board. The major heat-flow path from the package to the ambient is through the copper on the PCB. Maximizing the copper coverage is extremely important when the design does not include heat sinks attached to the PCB on the other side of the package.

Add as many thermal vias as possible directly under the package ground pad to optimize the thermal conductivity of the board.

All thermal vias should be either plated shut or plugged and capped on both sides of the board to prevent solder voids. To ensure reliability and performance, the solder coverage should be at least 85%.

11.2 Layout Example

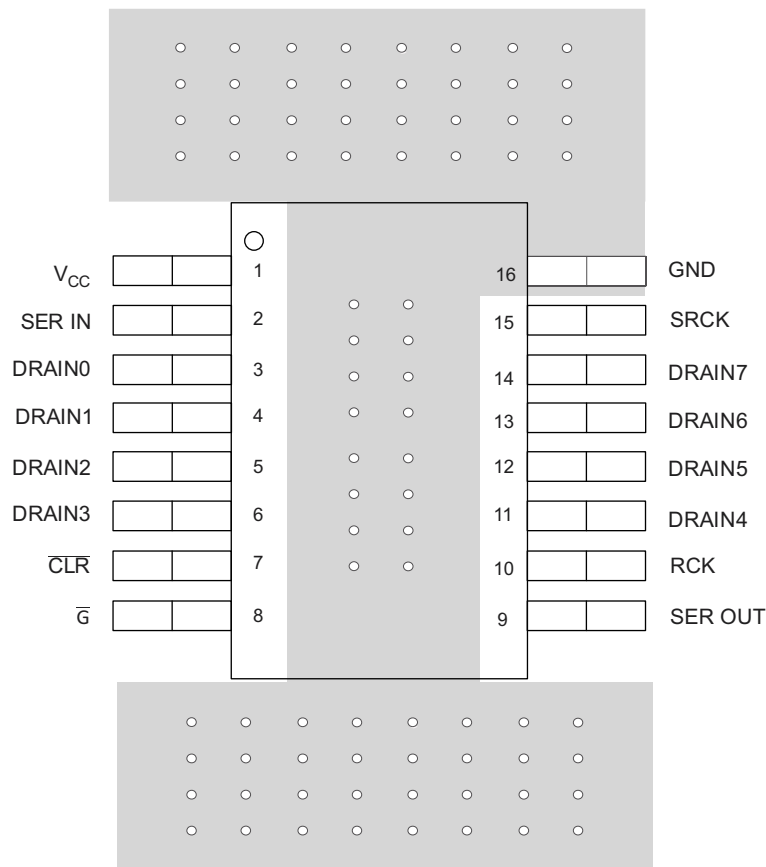


图 16. TLC6C598 Example Layout

12 デバイスおよびドキュメントのサポート

12.1 コミュニティ・リソース

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's [Terms of Use](#).

TI E2E™ Online Community *TI's Engineer-to-Engineer (E2E) Community*. Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

Design Support *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

12.2 商標

E2E is a trademark of Texas Instruments.
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12.3 静電気放電に関する注意事項



これらのデバイスは、限定的なESD(静電破壊)保護機能を内蔵しています。保存時または取り扱い時は、MOSゲートに対する静電破壊を防止するために、リード線同士をショートさせておくか、デバイスを導電フォームに入れる必要があります。

12.4 Glossary

[SLYZ022](#) — *TI Glossary*.

This glossary lists and explains terms, acronyms, and definitions.

13 メカニカル、パッケージ、および注文情報

以降のページには、メカニカル、パッケージ、および注文に関する情報が記載されています。これらの情報は、指定のデバイスに対して提供されている最新のデータです。このデータは予告なく変更されることがあり、ドキュメントが改訂される場合もあります。本データシートのブラウザ版を使用されている場合は、画面左側の説明をご覧ください。

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
TLC6C598PWR	Active	Production	TSSOP (PW) 16	2000 LARGE T&R	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 105	6C598I
TLC6C598PWR.A	Active	Production	TSSOP (PW) 16	2000 LARGE T&R	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 105	6C598I

⁽¹⁾ **Status:** For more details on status, see our [product life cycle](#).

⁽²⁾ **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

⁽⁴⁾ **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

⁽⁶⁾ **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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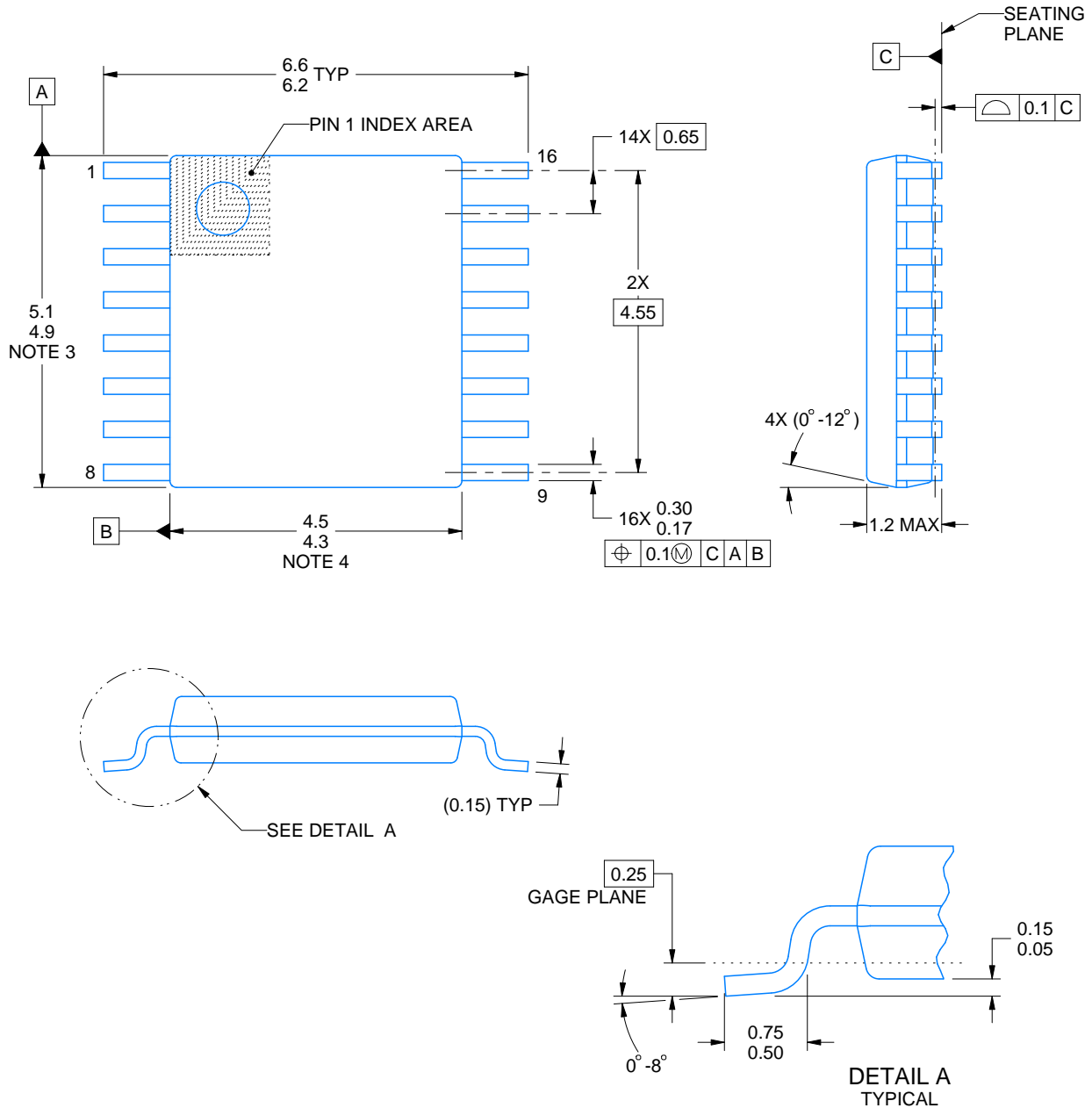
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OTHER QUALIFIED VERSIONS OF TLC6C598 :

- Automotive : [TLC6C598-Q1](#)

NOTE: Qualified Version Definitions:

- Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects



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NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
5. Reference JEDEC registration MO-153.

EXAMPLE BOARD LAYOUT

PW0016A

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE: 10X



SOLDER MASK DETAILS

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NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

PW0016A

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE: 10X

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NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

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